

588 West Jindu Road, Xingiao, Songjiang, 201612 Shanghai, China

Telephone: +86 (0) 21 6191 5666 Fax: +86 (0) 21 6191 5678

ee.shanghai@sgs.com

Report No.: SHEM160900629801

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# TEST REPORT

Application No.: SHEM1609006298IT

**Applicant:** Hangzhou Hikvision Digital Technology Co., Ltd.

Address of Applicant: No. 555 Qianmo Road, Binjiang District, Hangzhou 310052, China

Manufacturer: Hangzhou Hikvision Digital Technology Co., Ltd.

Address of Manufacturer: No. 555 Qianmo Road, Binjiang District, Hangzhou 310052, China

Factory: Hangzhou Hikvision Technology Co., Ltd.

Address of Factory: No. 700 Dongliu Road, Binjiang District, Hangzhou 310052, Zhejiang, China

**Equipment Under Test (EUT):** 

Product Description: Mobile Forensics system

Model No.: DS-MI7504-GA, DS-MI7502-GA, DS-MI7AXX-YY/ZZ/UU¤

Please refer to section 2 of this report which indicates which model was

actually tested and which were electrically identical.

Trade mark: Hikvision

**Standards**: EN 50130-4:2011+A1:2014, EN 55032:2015

EN 61000-3-2:2014, EN 61000-3-3:2013

**Date of Receipt**: 2016-10-13

**Date of Test**: 2016-10-17 to 2016-10-18

**Date of Issue**: 2016-10-27

Test Result : Pass\*

The CE mark as shown below can be used, under the responsibility of the manufacturer, after completion of an EC Declaration of Conformity and compliance with all relevant EU Directives.





### Parlam Zhan E&E Section Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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<sup>\*</sup> In the configuration tested, the EUT detailed in this report complied with the standards specified above.



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# 2 Test Summary

Item	Standard	Method	Class	Result
ESD	EN 50130- 4:2011+A1:2014	EN 61000-4-2:2009	6kV Contact Discharge 2,4,8kV Air Discharge	Pass
EFT(Mains)	EN 50130- 4:2011+A1:2014	EN 61000-4-4:2012	2kV 5/50ns Tr/Th 100kHz Repetition Frequency	Pass
EFT(Signal)	EN 50130- 4:2011+A1:2014	EN 61000-4-4:2012	1kV 5/50ns Tr/Th 100kHz Repetition Frequency	Pass
Surge(Mains)	EN 50130- 4:2011+A1:2014	EN 61000-4-5:2014	1.2/50µs Tr/Th 0.5,1kV Line to Line 0.5,1,2kV Line to Ground	Pass
V-Dips	EN 50130- 4:2011+A1:2014	EN 61000-4-11:2004	80 % UT for 250per 70 % UT for 25per 40 % UT for 10per 0 % UT for 250per UT is Supply Voltage	Pass
Mains Supply Voltage Variations- Conditioning	EN 50130- 4:2011+A1:2014	EN 50130- 4:2011+A1:2014	Unom+10% Unom-15%	Pass
RI(80M-2.7G)	EN 50130- 4:2011+A1:2014	EN 61000-4- 3:2006+A1:2008+A2: 2010	10V/m, 80%, 1kHz sinusoidal Amp. Mod.	Pass
CI M(150K-100M)	EN 50130- 4:2011+A1:2014	EN 61000-4-6:2014	10Vrms (emf),80%,1kHz sinusoidal Amp. Mod.	Pass
CI S(150K-100M)	EN 50130- 4:2011+A1:2014	EN 61000-4-6:2014	10Vrms (emf),80%,1kHz sinusoidal Amp. Mod.	Pass
CE M(150k-30M)	EN 55032:2015	EN 55032:2015	Class B	Pass
CE T(150K-30M)	EN 55032:2015	EN 55032:2015	Class B	Pass
RE(30M-1G)	EN 55032:2015	EN 55032:2015	Class B	Pass
RE(above1G)	EN 55032:2015	EN 55032:2015	Class B	Pass
Harmonic	EN 61000-3-2:2014	EN 61000-3-2:2014	Class A	N/A
Flicker	EN 61000-3-3:2013	EN 61000-3-3:2013	Clause 5 of EN 61000-3-3	Pass

N/A: Please refer to Section 6.5 of this report for details.

## **Declaration of EUT Family Grouping:**

There are series models mentioned in this report and they are the similar in electrical and electronic characters. Only the model DS-MI7504-GA was tested since their differences are Software version, their naming and color, silk



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# 4 General Information

## 4.1 Details of E.U.T.

Product Name: Mobile Forensics system

Power supply: DC9-32V 5.5A-1.6A

Contol cable: about 7m

Cable: AV out cable : about 7m

CH1 cable: about 7m

Power 50W

## 4.2 Description of Support Units

The EUT has been tested as an independent unit.

# 4.3 Standards Applicable for Testing

Table 1: Tests Carried Out Under EN 50130-4:2011+A1:2014

Method	Item	Status
EN 61000-4-2:2009	Electrostatic Discharge	√
EN 61000-4-4:2012	Electrical Fast Transients/Burst at Power Port	√
EN 61000-4-4:2012	Electrical Fast Transients/Burst at Signal Port	√
EN 61000-4-5:2014	Surge at Power Port	√
EN 61000-4-5:2014	Surge at Signal Port	×
EN 61000-4-11:2004	Voltage Dips and Interruptions	√
EN 50130-4:2011+A1:2014	Mains Supply Voltage Variations-Conditioning	√
EN 61000-4- 3:2006+A1:2008+A2:2010	Radiated Immunity(80MHz-2.7GHz)	√
EN 61000-4-6:2014	Conducted Immunity at Power Port(150kHz-100MHz)	√
EN 61000-4-4:2012	Electrical Fast Transients/Burst at DC port	×
EN 61000-4-5:2014	Surge at DC Port	×
EN 61000-4-6:2014	Conducted Immunity at Signal Port(150kHz-100MHz)	√
EN 61000-4-6:2014	Conducted Immunity at DC Port(150kHz-100MHz)	×



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#### Table 2: Tests Carried Out Under EN 55032:2015

Method	Item	Status
EN 55032:2015	Conducted Disturbance at Mains Terminals(150KHz-30MHz)	√
EN 55032:2015	Conducted Disturbance at Telecommunication Port(150KHz-30MHz)	√
EN 55032:2015	Conducted Disturbance at Antenna Terminals(30MHz-1GHz)	×
EN 55032:2015	Radiated Disturbance(30MHz-1GHz)	√
EN 55032:2015	Radiated Disturbance(above 1GHz)	√
EN 55032:2015	Conducted Disturbance at Antenna Terminals(30MHz-2.15GHz)	×

#### Table 3: Tests Carried Out Under EN 61000-3-2:2014

Method	Item	Status
EN 61000-3-2:2014	Harmonic Current Emission	×

#### Table 4: Tests Carried Out Under EN 61000-3-3:2013

Method	Item	Status
EN 61000-3-3:2013	Voltage Fluctuations and Flicker	√

- x Indicates that the test is not applicable
- $\sqrt{\phantom{a}}$  Indicates that the test is applicable



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#### 4.4 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. E&E Lab 588 West Jindu Road, Xingiao, Songjiang, 201612 Shanghai, China

Tel: +86 21 6191 5666 Fax: +86 21 6191 5678

No tests were sub-contracted.

# 4.5 Test Facility

### • CNAS (No. CNAS L0599)

CNAS has accredited SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

#### • FCC - Registration No.: 402683

SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered and fully described in a report filed with the Federal Communications Commission (FCC). The acceptance letter from the FCC is maintained in our files. Registration No.: 402683.

#### Industry Canada (IC) – IC Assigned Code: 8617A

The 3m Semi-anechoic chamber of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 8617A-1.

### • VCCI (Member No.: 3061)

The 3m Semi-anechoic chamber and Shielded Room of SGS-CSTC Standards Technical Services (Shanghai) Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-3868,C-4336,T-2221,G-830 respectively.

#### 4.6 Deviation from Standards

None

### 4.7 Abnormalities from Standard Conditions

None

# 4.8 Monitoring of EUT for All Immunity Test

Visual: work status & image quality



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# 4.9 Measurement Uncertainty

According to CISPR 16-4-2.

Test Item	Frequency Range	Measurement Uncertainty	$U_{cispr}$
Conducted Emission at mains port using AMN	9kHz-150kHz	3.2 dB	3.8 dB
Conducted Emission at mains port using AMN	150kHz-30MHz	3.0 dB	3.4 dB
Conducted Emission at mains port using VP	9kHz-30MHz	1.9 dB	3.9 dB
Conducted Emission at telecommunication port using AAN	150kHz-30MHz	2.4 dB	5.0 dB
Radiated Emission	30MHz-1000MHz	4.4 dB	6.3 dB
Radiated Emission	1GHz-6GHz	4.6 dB	5.2 dB (1GHz-6GHz)
Radiated Emission	6GHz-18GHz	4.6 dB	5.5 dB (6GHz-18GHz)
Disturbance Power	30MHz-300MHz	3.5 dB	4.5 dB

#### Remark:

AMN - Artificial Mains Network

VP - Voltage Probe

ANN - Asymmetric Artificial Network

Note: The measurement uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.



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# 5 Equipment List

ESD						
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
1	ELECTROSTATIC DISCHARGE SIMULATOR	TESEQ	NSG 437	SHEM041-1	2016-08-15	2017-08-14

EFT(N	EFT(Mains)					
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
1	IMMUNITY TEST SYSTEM	EMC PARTNER	TRA3000 F- S-D-V	SHEM163-1	2016-01-14	2017-01-13
2	MATCHING RESISTORS FOR EFT/BURST GENERATORS	EM TEST	KW50	SHEM026-4	2016-01-14	2017-01-13
3	MATCHING RESISTORS FOR EFT/BURST GENERATORS	EM TEST	KW1000	SHEM026-5	2016-01-14	2017-01-13

EFT(S	EFT(Signal)					
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date
1	IMMUNITY TEST SYSTEM	EMC PARTNER	TRA3000 F- S-D-V	SHEM163-1	2016-01-14	2017-01-13
2	CAPACITIVE COUPLING CLAMP	EM TEST	HFK	SHEM026-2	2016-08-12	2017-08-11
3	DATA COUPLING NETWORK 4 LINE	EM TEST	CNV 504	SHEM026-3	2016-08-12	2017-08-11
4	MATCHING RESISTORS FOR EFT/BURST GENERATORS	EM TEST	KW50	SHEM026-4	2016-01-14	2017-01-13
5	MATCHING RESISTORS FOR EFT/BURST GENERATORS	EM TEST	KW1000	SHEM026-5	2016-01-14	2017-01-13

Sur	Surge(Mains)						
Iter	n Equipment	Manufacturer	Model No	Inventory No	Cal Date	<b>Cal Due Date</b>	
1	IMMUNITY TEST SYSTEM	EMC PARTNER	TRA3000 F- S-D-V	SHEM163-1	2016-01-14	2017-01-13	

V-Dip	V-Dips								
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date			
1	IMMUNITY TEST SYSTEM	EMC PARTNER	TRA3000 F- S-D-V	SHEM163-1	2016-01-14	2017-01-13			

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Mains	Mains Supply Voltage Variations-Conditioning								
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date			
1	IMMUNITY TEST SYSTEM	EMC PARTNER	TRA3000 F- S-D-V	SHEM163-1	2016-01-14	2017-01-13			

RI(80I	RI(80M-2.7G)									
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date				
1	SIGNAL GENERATOR	ROHDE & SCHWARZ	SMJ100A	SHEM141-1	2016-01-13	2017-01-12				
2	POWER METER	ROHDE & SCHWARZ	NRP	SHEM057-1	2016-01-14	2017-01-13				
3	POWER METER SENSOR	ROHDE & SCHWARZ	NRP-Z91	NRP-Z91 SHEM057-2		2017-01-13				
4	ANTENNA	SCHWARZBECK	STLP9128D	LP9128D SHEM130-1 N/A		N/A				
5	ANTENNA	SCHWARZBECK	STLP9149	STLP9149 SHEM131-1 N/A		N/A				
6	AMPLIFIER	MILMEGA	80RF1000- 250	SHEM132-1   N/A		N/A				
7	AMPLIFIER	MILMEGA	AS0840-55- 55	SHEM133-1	N/A	N/A				
8	POWER METER SENSOR	ROHDE & SCHWARZ	NRP-Z22	NRP-Z22 SHEM136-1 201		2017-08-11				
9	ELECTROMAGNETI C FIELD PROBE	ETS-LINDGREN	HI-6113	HI-6113 SHEM134-1 2016-08-12		2017-08-11				
10	SEMI/FULLY ANECHOIC	ST	11*6*6M	SHEM078-2	2016-08-17	2017-08-16				

CI M(	CI M(150K-100M)									
Item	Equipment	Manufacturer	Model No	<b>Inventory No</b>	Cal Date	Cal Due Date				
1	SIGNAL GENERATOR	ROHDE & SCHWARZ	SMJ100A	SHEM141-1	2016-01-13	2017-01-12				
2	PAMP CONDUCTED RF TEST SYSTEM	HAEFFLY	PAMP250	SHEM023-1	2016-01-14	2017-01-13				
3	6DB ATTENUATOR	HUAXIANG	TST-150-761	SHEM151-1	N/A	N/A				
4	CDN IMPEDANCE AND K-FACTOR	LUTHI	L-801 M1	SHEM023-5	2016-01-14	2017-01-13				
5	CDN IMPEDANCE AND K-FACTOR	LUTHI	L-801 M2/M3	SHEM023-6	2016-03-07	2017-03-06				
6	SHIELDING ROOM	ZHONGYU	5*5*3M	SHEM079-6	2016-08-17	2017-08-16				



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CI S(1	CI S(150K-100M)									
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date				
1	SIGNAL GENERATOR	ROHDE & SCHWARZ	SMJ100A	101394	2016-01-14	2017-01-13				
2	PAMP CONDUCTED RF TEST SYSTEM	HAEFFLY	PAMP250	151708	2016-01-14	2017-01-13				
3	CDN IMPEDANCE AND K-FACTOR	LUTHI	L-801 M1	2116	2016-01-14	2017-01-13				
4	CDN IMPEDANCE AND K-FACTOR	LUTHI	L-801 M2/M3	2117	2016-01-14	2017-01-13				

CE M	CE M(150k-30M)									
Item	n Equipment Manufactur		Model No	Model No Inventory No		Cal Due Date				
1	EMI TEST RECEIVER	ROHDE & SCHWARZ	ESR7	SHEM162-1	2016-01-13	2017-01-12				
2	LINE IMPEDANCE STABILIZATION NETWORK	SCHWARZBECK	NSLK8127	SHEM061-1	2016-01-14	2017-01-13				
3	LINE IMPEDANCE STABILIZATION NETWORK	IZATION EMCO		SHEM019-1	2016-01-14	2017-01-13				
4	PULSE LIMITER	ROHDE & SCHWARZ	ESH3-Z2	SHEM029-1	2016-08-12	2017-08-11				
5	SHIELDING ROOM	ZHONGYU	8*4*3M	SHEM079-2	2016-08-17	2017-08-16				

CE T(	CE T(150K-30M)									
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date				
1	EMI TEST RECEIVER	ROHDE & SCHWARZ	ESR7	SHEM162-1	2016-01-13	2017-01-12				
2	LINE IMPEDANCE STABILIZATION NETWORK	ILIZATION SCHWARZBECK		SHEM061-1	2016-01-14	2017-01-13				
3	LINE IMPEDANCE STABILIZATION NETWORK	ABILIZATION EMCO		SHEM019-1	2016-01-14	2017-01-13				
4	8-WIRE ISN CAT 5	SCHWARZBECK	CAT5 8158	SHEM137-1	2016-01-14	2017-01-13				
5	8-WIRE ISN CAT 3	SCHWARZBECK	CAT3 8158	SHEM137-2	2016-01-14	2017-01-13				
6	8-WIRE ISNCAT 6	SCHWARZBECK	NTFM8158	SHEM137-3 2016-01-1		2017-01-13				
7	2-DRAHT ISN	SCHWARZBECK - MESS- ELEKTRONIK	NTFM 8131	SHEM139-1	2016-01-14	2017-01-13				
8	PULSE LIMITER	ROHDE & SCHWARZ	ESH3-Z2	SHEM029-1	2016-08-12	2017-08-11				
9	SHIELDING ROOM	ZHONGYU	8*4*3M	SHEM079-2	2016-08-17	2017-08-16				

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RE(30	RE(30M-1G)									
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date				
1	EMI TEST RECEIVER	ROHDE & SCHWARZ	ESU40	SHEM051-1	2016-08-12	2017-08-11				
2	CONTROLLER	INNCO	CO200	SHEM047-1	N/A	N/A				
3	ANTENNA MAST	INNCO	MA400-EP	SHEM047-2	N/A	N/A				
4	TURN DEVICE	INNCO	DE 3600-RH	SHEM047-3 N/A		N/A				
5	BROADBAND UHF- VHF ANTENNA	SCHWARZBECK	VULB9168	SHEM048-1	2016-01-16	2017-01-15				
6	LOW FREQUENCY AMPLIFIER	CLAVIIO	BDLNA-0001- 412010	SHEM164-1	2016-08-12	2017-08-11				
7	SEMI/FULLY ANECHOIC	ST	11*6*6M	SHEM078-2	2016-08-17	2017-08-16				

RE(ab	RE(above1G)									
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date				
1	EMI TEST RECEIVER	ROHDE & SCHWARZ	ESU40	SHEM051-1	2016-08-12	2017-08-11				
2	CONTROLLER	INNCO	CO200	CO200 SHEM047-1		N/A				
3	ANTENNA MAST	INNCO	MA400-EP	SHEM047-2	N/A	N/A				
4	TURN DEVICE	INNCO	DE 3600-RH	SHEM047-3	N/A	N/A				
5	DOUBLE RIDGED BROADBAND HORN ANTENNA	SCHWARZBECK	BBHA9120D	SHEM050-1	2016-01-16	2017-01-15				
6	HIGH-AMPLIFIER	SCHWARZBECK	SCU-F0118- G40-BZ4-CS	SHEM050-2	2016-01-14	2017-01-13				
7	SEMI/FULLY ANECHOIC	ST	11*6*6M	SHEM078-2	2016-08-17	2017-08-16				

Flicke	Flicker								
Item	Equipment	Manufacturer	Model No	Inventory No	Cal Date	Cal Due Date			
1	HARMONIC&FLICKE R ANALYZER	AMETEK	PACS-1	SHEM024-2	2016-09-06	2017-09-05			
2	AC POWER SOURCE 5KVA	AMETEK	5001IX	SHEM025-2	2016-09-06	2017-09-05			



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Gene	General used equipment									
Item	Test Equipment	Manufacturer	Model No.	Serial No.	Cal. date	Cal.Due date				
1	Digital pressure meter	YONGZHI	DYM3-01	101012	2016-03-03	2017-03-02				
2	Temperature&humidit y recorder	ShangHai weather meter work	ZJ 1-2B	84320600 803136, F304020153,20 101201FS100A 6K,201106117	2016-08-03	2017-08-02				
3	Digital Multimeter	FLUKE	17B	19720439	2016-01-14	2017-01-13				
4	Autoformer regulator	Guangzhou bao de	TDGC2-5KVA	N/A	N/A	N/A				
5	CLAMP METER	FLUKE	316	2503030971	2016-01-14	2017-01-13				



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# 6 Emission Test Results

# 6.1 CE M(150k-30M)

Test Requirement: EN 55032:2015
Test Method: EN 55032:2015
Frequency Range: 150kHz to 30MHz

Limit:

0.15M-0.5MHz 66dB( $\mu$ V)-56dB( $\mu$ V) quasi-peak, 56dB( $\mu$ V)-46dB( $\mu$ V) average

0.5M-5MHz 56dB( $\mu$ V) quasi-peak, 46dB( $\mu$ V) average 5M-30MHz 60dB( $\mu$ V) quasi-peak, 50dB( $\mu$ V) average

Detector: Peak for pre-scan (9kHz resolution bandwidth) 0.15M to 30MHz

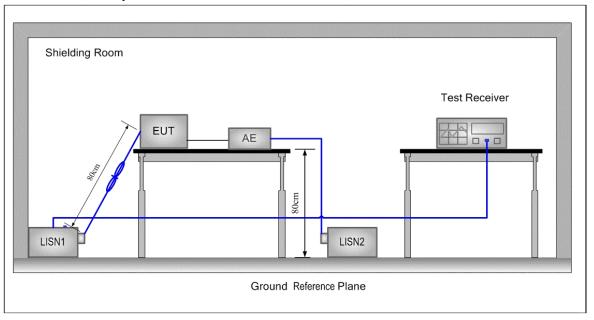
#### 6.1.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:50 % RH Atmospheric Pressure: 1001 mbar

Test mode a:working mode: keep EUT working and monitoring continual.

### 6.1.2 Test Setup



#### 6.1.3 Measurement Data

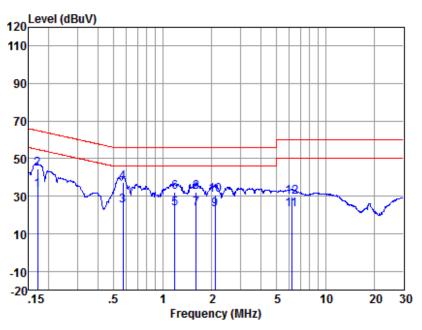
An initial pre-scan was performed with peak detector. Quasi-Peak or Average measurement were performed at the frequencies with maximized peak emission were detected.



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#### Mode:a;Line:Live Line



Site : chamber Condition : LISN-L-2016

EUT/Project No: 6298IT

Test mode : a

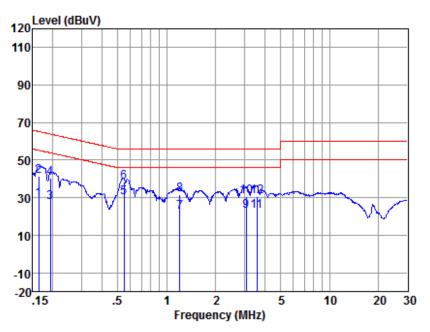
Read LISN Cable Limit 0ver Freq Level Factor Loss Level Line Limit Remark dBuV MHz dBuV dB dB dBuV dB 1 0.170 23.09 0.07 10.15 33.31 54.94 -21.63 Average 2 0.170 34.42 0.07 10.15 44.64 64.94 -20.30 QP 3 0.570 14.61 0.10 10.17 24.88 46.00 -21.12 Average 4 0.570 27.02 0.10 10.17 37.29 56.00 -18.71 QP 5 1.184 12.95 0.08 10.18 23.21 46.00 -22.79 Average 1.184 22.06 0.08 10.18 32.32 56.00 -23.68 QP 6 7 1.610 13.23 0.08 10.19 23.50 46.00 -22.50 Average 8 1.610 22.02 0.08 10.19 32.29 56.00 -23.71 QP 9 2.099 12.51 0.08 10.19 22.78 46.00 -23.22 Average 10 2.099 20.57 0.08 10.19 30.84 56.00 -25.16 QP 11 6.219 12.45 0.16 10.27 22.88 50.00 -27.12 Average 12 6.219 19.30 0.16 10.27 29.73 60.00 -30.27 QP



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## Mode:a;Line:Neutral Line



Site : chamber Condition : LISN-N-2016

EUT/Project No: 6298IT

Test mode : a

		Read	LISN	Cable		Limit	0ver	
	Freq	Level	Factor	Loss	Level	Line	Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
								_
1	0.163	19.11	0.05	10.15	29.31	55.30	-25.99	Average
2	0.163	31.23	0.05	10.15	41.43	65.30	-23.87	QP
3	0.192	17.19	0.05	10.15	27.39	53.93	-26.54	Average
4	0.192	30.37	0.05	10.15	40.57	63.93	-23.36	QP
5	0.546	19.84	0.04	10.17	30.05	46.00	-15.95	Average
6	0.546	28.27	0.04	10.17	38.48	56.00	-17.52	QP
7	1.203	11.94	0.05	10.18	22.17	46.00	-23.83	Average
8	1.203	21.46	0.05	10.18	31.69	56.00	-24.31	QP
9	3.074	12.50	0.12	10.20	22.82	46.00	-23.18	Average
10	3.074	20.05	0.12	10.20	30.37	56.00	-25.63	QP
11	3.584	12.50	0.14	10.21	22.85	46.00	-23.15	Average
12	3.584	20.37	0.14	10.21	30.72	56.00	-25.28	QP



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# 6.2 CE T(150K-30M)

Test Requirement: EN 55032:2015
Test Method: EN 55032:2015
Frequency Range: 150kHz to 30MHz

Limit:

0.15M-0.5MHz 84dB( $\mu$ V)-74dB( $\mu$ V) quasi-peak, 74dB( $\mu$ V)-64dB( $\mu$ V) average

0.5M-30MHz 74dB( $\mu$ V) quasi-peak, 64dB( $\mu$ V) average

Detector: Peak for pre-scan (9kHz resolution bandwidth) 0.15M to 30MHz

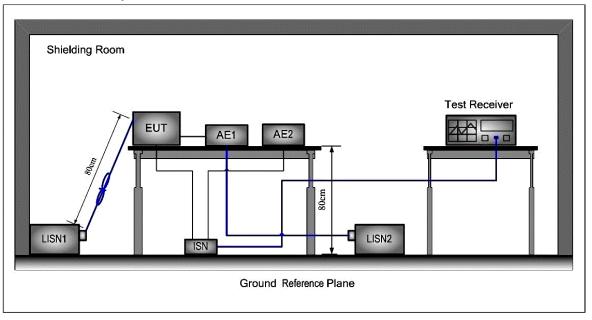
### 6.2.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:50 % RH Atmospheric Pressure: 1001 mbar

Test mode a:working mode: keep EUT working and monitoring continual.

#### 6.2.2 Test Setup



#### 6.2.3 Measurement Data

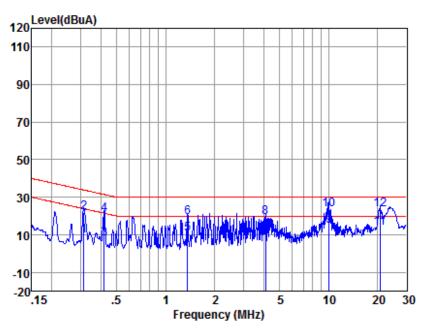
An initial pre-scan was performed with peak detector. Quasi-Peak or Average measurement were performed at the frequencies with maximized peak emission were detected.



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#### Mode:a



Site : chamber

Condition :

EUT/Project No: 6298IT

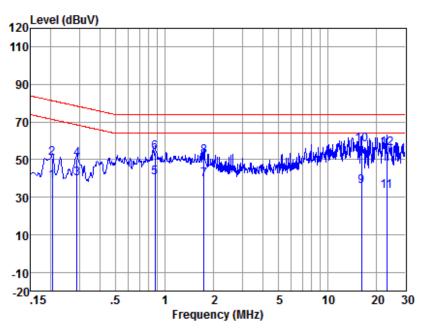
Test mode : a

		Read	Aux	Cable		Limit	0ver	
	Freq	Level	Factor	Loss	Level	Line	Limit	Remark
	MHz	dBuA	dB	dB	dBuA	dBuA	dB	
1	0.315	-35.63	35.08	10.16	9.61	23.84	-14.23	Average
2	0.315	-23.63	35.08	10.16	21.61	33.84	-12.23	QP
3	0.419	-39.38	36.96	10.17	7.75	21.46	-13.71	Average
4	0.419	-26.38	36.96	10.17	20.75	31.46	-10.71	QP
5	1.367	-42.10	42.37	10.19	10.46	20.00	-9.54	Average
6	1.367	-33.10	42.37	10.19	19.46	30.00	-10.54	QP
7	4.114	-43.38	43.61	10.22	10.45	20.00	-9.55	Average
8	4.114	-34.38	43.61	10.22	19.45	30.00	-10.55	QP
9	10.072	-39.35	43.70	10.11	14.46	20.00	-5.54	Average
10	10.072	-30.35	43.70	10.11	23.46	30.00	-6.54	QP
11	20.814	-40.53	43.59	10.37	13.43	20.00	-6.57	Average
12	20.814	-30.53	43.59	10.37	23.43	30.00	-6.57	OP



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Site : chamber

Condition :

EUT/Project No: 6298IT

Test mode : a

	Freq	Read Level	LISN Factor	Cable Loss	Level	Limit Line	Over Limit	Remark
	MHz	dBuV	dB	dB	dBuV	dBuV	dB	
1	0.204	4.34	23.90	10.15	38.39	71.45	-33.06	Average
2	0.204	16.77	23.90	10.15	50.82	81.45	-30.63	QP
3	0.289	6.61	23.41	10.16	40.18	68.54	-28.36	Average
4	0.289	16.51	23.41	10.16	50.08	78.54	-28.46	QP
5	0.876	7.19	23.30	10.18	40.67	64.00	-23.33	Average
6	0.876	20.25	23.30	10.18	53.73	74.00	-20.27	QP
7	1.744	6.02	23.30	10.19	39.51	64.00	-24.49	Average
8	1.744	18.27	23.30	10.19	51.76	74.00	-22.24	QP
9	16.226	4.16	21.15	10.30	35.61	64.00	-28.39	Average
10	16.226	26.54	21.15	10.30	57.99	74.00	-16.01	QP
11	23.140	-10.32	33.15	10.40	33.23	64.00	-30.77	Average
12	23.140	12.62	33.15	10.40	56.17	74.00	-17.83	QP



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# 6.3 RE(30M-1G)

Test Requirement: EN 55032:2015
Test Method: EN 55032:2015
Frequency Range: 30MHz to 1GHz

Limit:

30MHz-230MHz 40 dB( $\mu$ V/m) quasi-peak 230MHz-1GHz 47 dB( $\mu$ V/m) quasi-peak

Detector: Peak for pre-scan (120kHz resolution bandwidth) 30M to 1000MHz

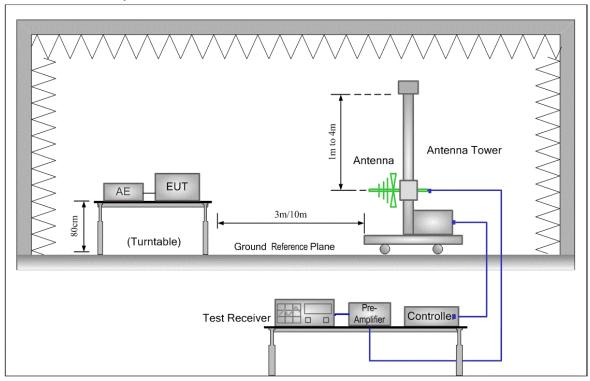
### 6.3.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:50 % RH Atmospheric Pressure: 1005 mbar

Test mode a:working mode: keep EUT working and monitoring continual.

#### 6.3.2 Test Setup



#### 6.3.3 Measurement Data

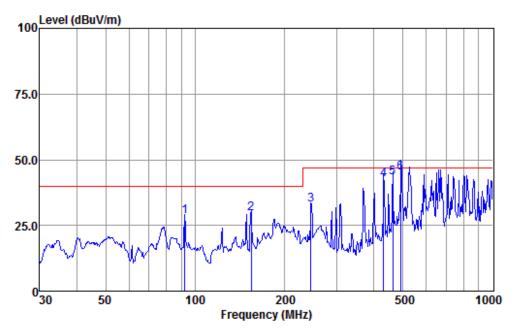
An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.



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### Mode:a;Polarization:Horizontal



Condition : HORIZONTAL EUT/Project: 6298IT

Test mode : a

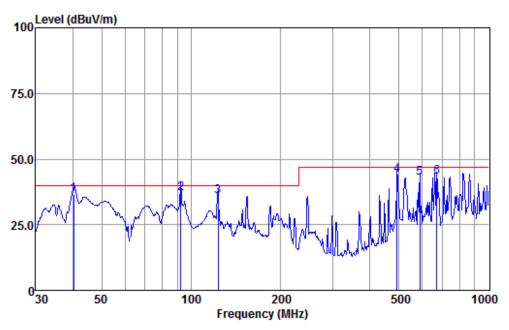
		ReadA	ntenna	Cable	Preamp		Limit	0ver	
	Freq	Level	Factor	Loss	Factor	Level	Line	Limit	Remark
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	92.46	61.90	8.91	1.07	43.61	28.27	40.00	-11.73	QP
2	154.28	59.19	12.49	1.39	43.48	29.59	40.00	-10.41	QP
3	245.09	62.70	11.60	1.80	43.36	32.74	47.00	-14.26	QP
4	431.03	67.18	16.05	2.53	43.22	42.54	47.00	-4.46	QP
5	462.35	67.36	16.45	2.61	43.20	43.22	47.00	-3.78	QP
6 a	491.00	68.45	17.10	2.73	43.18	45.10	47.00	-1.90	OP



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Mode:a;Polarization:Vertical



Condition : VERTICAL EUT/Project: 6298IT

Test mode : a

		ReadA	ntenna	Cable	Preamp		Limit	0ver	
	Freq	Level	Factor	Loss	Factor	Level	Line	Limit	Remark
_									
	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	40.28	66.17	13.56	0.60	43.82	36.51	40.00	-3.49	QP
2	92.46	70.56	8.91	1.07	43.61	36.93	40.00	-3.07	QP
3	123.27	66.40	11.83	1.23	43.54	35.92	40.00	-4.08	QP
4 q	492.47	67.27	17.13	2.74	43.18	43.96	47.00	-3.04	QP
5	586.84	62.66	20.28	3.00	43.14	42.80	47.00	-4.20	QP
6	670.49	62.96	19.92	3.27	43.10	43.05	47.00	-3.95	QP



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# 6.4 RE(above1G)

Test Requirement: EN 55032:2015
Test Method: EN 55032:2015
Frequency Range: Above 1GHz

Limit:

1GHz-3GHz 70 dB( $\mu$ V/m) peak, 50 dB( $\mu$ V/m) average 3GHz-6GHz 74 dB( $\mu$ V/m) peak, 54dB( $\mu$ V/m) average

Detector: Peak for pre-scan (1000kHz resolution bandwidth) 1000M to 6000MHz

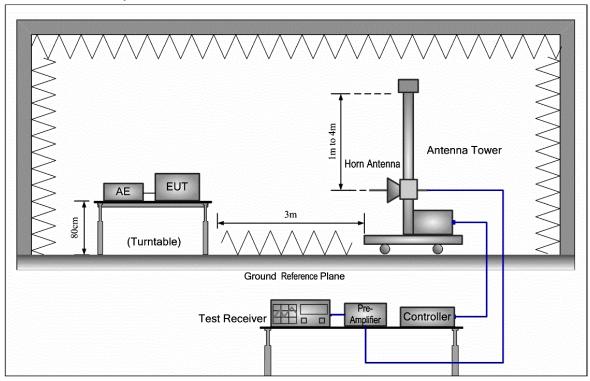
#### 6.4.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:50 % RH Atmospheric Pressure: 1005 mbar

Test mode a:working mode: keep EUT working and monitoring continual.

#### 6.4.2 Test Setup



### 6.4.3 Measurement Data

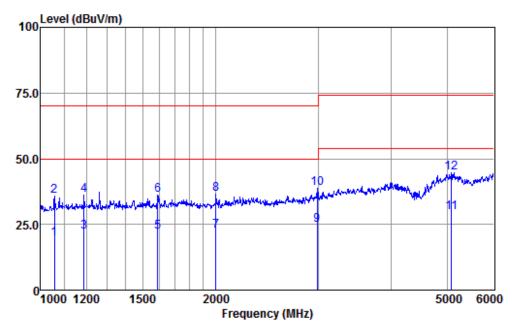
An initial pre-scan was performed in the chamber using the spectrum analyser in peak detection mode. Quasi-peak measurements were conducted based on the peak sweep graph. The EUT was measured by BiConiLog antenna with 2 orthogonal polarities.



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### Mode:a;Polarization:Horizontal



Condition : HORIZONTAL EUT/Project: 6298IT

Test Mode : a

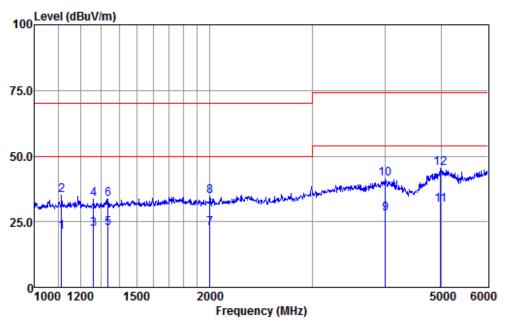
		Kead	Antenna	Capie	Preamp		Limit	Over	
	Freq	Level	Factor	Loss	Factor	Level	Line	Limit	Remark
-	MHz	dBuV	dB/m	dB	dB	dBuV/m	dBuV/m	dB	
1	1057.12	32.67	24.57	3.20	40.76	19.68	50.00	-30.32	Average
2	1057.12	48.72	24.57	3.20	40.76	35.73	70.00	-34.27	Peak
3	1187.69	34.59	24.71	3.39	40.68	22.01	50.00	-27.99	Average
4	1187.69	48.80	24.71	3.39	40.68	36.22	70.00	-33.78	Peak
5	1590.53	33.36	25.44	3.94	40.67	22.07	50.00	-27.93	Average
6	1590.53	47.53	25.44	3.94	40.67	36.24	70.00	-33.76	Peak
7	2000.53	32.25	27.10	4.45	41.23	22.57	50.00	-27.43	Average
8	2000.53	46.19	27.10	4.45	41.23	36.51	70.00	-33.49	Peak
9	2988.48	30.76	29.26	5.35	40.82	24.55	50.00	-25.45	Average
10	2988.48	44.86	29.26	5.35	40.82	38.65	70.00	-31.35	Peak
11	5079.06	26.54	37.68	7.02	41.68	29.56	54.00	-24.44	Average
12 p	5079.06	41.63	37.68	7.02	41.68	44.65	74.00	-29.35	Peak



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Mode:a;Polarization:Vertical



Condition : VERTICAL EUT/Project: 6298IT Test Mode : a

ReadAntenna Cable Preamp Limit 0ver Loss Factor Level Factor Level Line Limit Remark Freq MHz dB dBuV/m dBuV/m dBuV dB/m dB dB 1 1113.50 34.06 24.63 3.09 40.73 21.05 50.00 -28.95 Average 48.21 35.20 2 1113.50 24.63 3.09 40.73 70.00 -34.80 Peak 3 34.56 3.57 40.64 22.28 50.00 -27.72 Average 1262.29 24.79 45.76 40.64 33.48 4 1262.29 24.79 3.57 70.00 -36.52 Peak 34.36 22.38 5 1336.78 24.86 3.76 40.60 50.00 -27.62 Average 1336.78 45.57 3.76 40.60 33.59 70.00 -36.41 Peak 6 24.86 7 2000.53 32.15 27.10 4.45 41.23 22.47 50.00 -27.53 Average 8 2000.53 44.28 27.10 4.45 41.23 34.60 70.00 -35.40 Peak 9 4009.29 28.45 32.70 6.96 40.05 28.06 54.00 -25.94 Average 4009.29 41.54 32.70 6.96 40.05 41.15 74.00 -32.85 Peak 10 28.11 41.71 54.00 -22.48 Average 11 4988.86 38.08 7.04 31.52 12 p 4988.86 42.08 38.08 7.04 41.71 45.49 74.00 -28.51 Peak



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### 6.5 Harmonic

Test Requirement: EN 61000-3-2:2014
Test Method: EN 61000-3-2:2014
Frequency Range: 100Hz to 2kHz

There is no need for Harmonics test to be performed on this product (rated power is less than 75W) in accordance with EN 61000-3-2.

For further details, please refer to Clause 7 of EN 61000-3-2 which states:

"For the following categories of equipment, limits are not specified in this standard.- equipment with a rated power of 75W or less, other than lighting equipment."



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# 6.6 Flicker

Test Requirement: EN 61000-3-3:2013 Test Method: EN 61000-3-3:2013

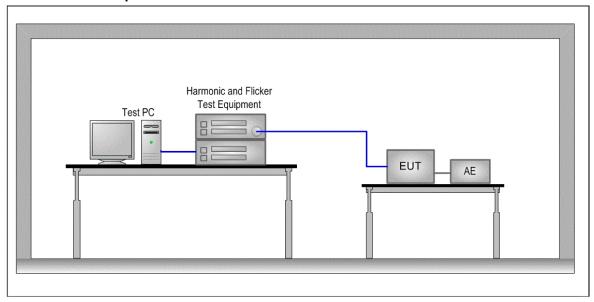
### 6.6.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:50 % RH Atmospheric Pressure: 1010 mbar

Test mode a:working mode: keep EUT working and monitoring continual.

#### 6.6.2 Test Setup



### 6.6.3 Measurement Data

#### Mode:a

Parameter values recorded during the test:

Vrms at the end of test (Volt): 229.90

Test limit (mS): 500.0 T-max (mS): **Pass** O Highest dc (%): 0.00 Test limit (%): 3.30 **Pass** Highest dmax (%): Highest Pst (10 min. period): Test limit (%): 0.23 4.00 **Pass** Test limit: 0.207 1.000 **Pass** Highest Plt (2 hr. period): **Test limit: Pass** 0.090 0.650



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# 7 Immunity Test Results

# 7.1 Performance Criteria Description in EN 50130-4:2011+A1:2014

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change.

For further details, please refer to Clause 7.4, 8.4, 9.4, 10.4, 11.4, 12.4 and 13.4, of EN 50130-4.



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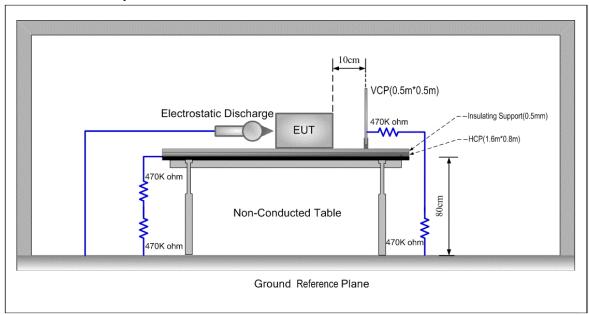
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### 7.2 **ESD**

Test Requirement: EN 50130-4:2011+A1:2014

Test Method: EN 61000-4-2:2009

### 7.2.1 Test Setup:



### 7.2.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:52 % RH Atmospheric Pressure: 1004 mbar

Test mode: a:working mode: keep EUT working and monitoring continual.

#### 7.2.3 Test Results:

Observations: Test Point:

1. All insulated enclosure and seams.

2. All accessible metal parts of the enclosure.

3. All side

Discharge type	Level (kV)	Polarity	Test Point	Result / Observations
Air Discharge	2,4,8	+	1	A
Air Discharge	2,4,8	-	1	Α
Contact Discharge	6	+	2	А
Contact Discharge	6	-	2	А
Horizontal Coupling	6	+	3	А
Horizontal Coupling	6	-	3	А
Vertical Coupling	6	+	3	A
Vertical Coupling	6	-	3	A

#### Results:

A: No degradation in the performance of the EUT was observed.

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# 7.3 EFT(Mains)

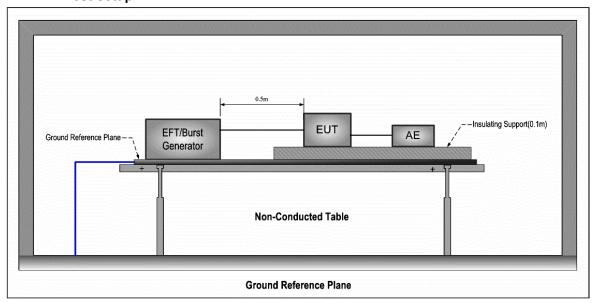
Test Requirement: EN 50130-4:2011+A1:2014

Test Method: EN 61000-4-4:2012

Repetition Frequency: 100kHz

Test Duration: 1 minute per level & polarity

### 7.3.1 Test Setup:



## 7.3.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:52 % RH Atmospheric Pressure: 1004 mbar

Test mode: a:working mode: keep EUT working and monitoring continual.

# 7.3.3 Test Results:

Test Line	Level (kV)	Polarity	Direct/Coupling	Result / Observations
AC power port	2	+	Direct	А
AC power port	2	•	Direct	А

#### Results:

A: No degradation in the performance of the EUT was observed.



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# 7.4 EFT(Signal)

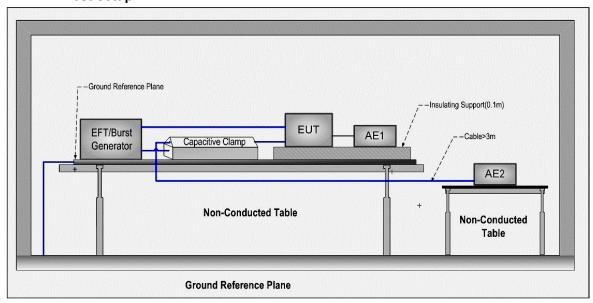
Test Requirement: EN 50130-4:2011+A1:2014

Test Method: EN 61000-4-4:2012

Repetition Frequency: 100kHz

Test Duration: 1 minute per level & polarity

#### 7.4.1 Test Setup:



## 7.4.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:52 % RH Atmospheric Pressure: 1004 mbar

Test mode: a:working mode: keep EUT working and monitoring continual.

#### 7.4.3 Test Results:

Cable port	Level (kV)	Polarity	Direct/Coupling	Result / Observations
Signal port	1	+	Coupling clamp	А
Signal port	1	•	Coupling clamp	А

#### Results:

A: No degradation in the performance of the EUT was observed.



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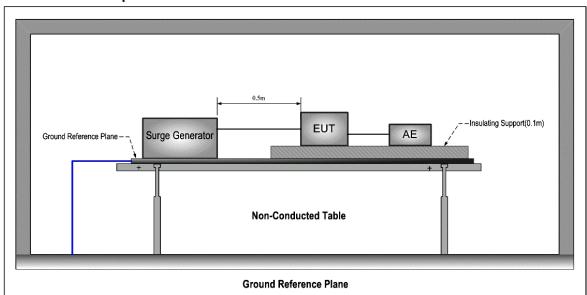
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# 7.5 Surge(Mains)

Test Requirement: EN 50130-4:2011+A1:2014

Test Method: EN 61000-4-5:2014

### 7.5.1 Test Setup:



### 7.5.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:52 % RH Atmospheric Pressure: 1004 mbar

Test mode: a:working mode: keep EUT working and monitoring continual.

#### 7.5.3 Test Results:

Test Line	Level (kV)	Polarity	Phase (deg)	Result / Observations
L-N	0.5,1	+	0°	Α
L-N	0.5,1	-	0°	Α
L-N	0.5,1	+	90°	Α
L-N	0.5,1	-	90°	Α
L-N	0.5,1	+	180°	Α
L-N	0.5,1	-	180°	Α
L-N	0.5,1	+	270°	Α
L-N	0.5,1	-	270°	А
L-PE	0.5,1,2	+	0°	А
L-PE	0.5,1,2	-	0°	Α
L-PE	0.5,1,2	+	90°	А
L-PE	0.5,1,2	-	90°	А
L-PE	0.5,1,2	+	180°	А

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L-PE	0.5,1,2	-	180°	А
L-PE	0.5,1,2	+	270°	А
L-PE	0.5,1,2	-	270°	А
N-PE	0.5,1,2	+	0°	Α
N-PE	0.5,1,2	-	0°	А
N-PE	0.5,1,2	+	90°	А
N-PE	0.5,1,2	•	90°	А
N-PE	0.5,1,2	+	180°	А
N-PE	0.5,1,2	-	180°	А
N-PE	0.5,1,2	+	270°	А
N-PE	0.5,1,2	-	270°	А

#### Results:

A: No degradation in the performance of the EUT was observed.



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7.6 V-Dips

Test Requirement: EN 50130-4:2011+A1:2014
Test Method: EN 61000-4-11:2004

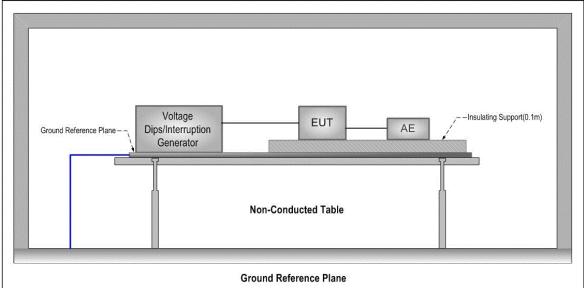
Performance Criterion: 0% of UT (Supply Voltage) for 250 Periods; 40% of UT for 10 Periods;

70% of UT for 25 Periods; 80% of UT for 250 Periods;

No. of Dips / Interruptions: 3 per Level

Time between dropout 10s

### 7.6.1 Test Setup:



#### 7.6.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:52 % RH Atmospheric Pressure: 1004 mbar

Test mode: a:working mode: keep EUT working and monitoring continual.

#### 7.6.3 Test Results:

Level % UT	Phase (deg)	Duration	No. of Dips /	Result / Observations
80	0°	250 Periods	3	Α
80	180°	250 Periods	3	Α
70	0°	25 Periods	3	А
70	180°	25 Periods	3	Α
40	0°	10 Periods	3	Α
40	180°	10 Periods	3	Α
0	0°	250 Periods	3	В
0	180°	250 Periods	3	В

### Results:

A: No degradation in the performance of the EUT was observed.

B: During test, EUT stop work, After test, which the equipment under test recovers its normal Performance.

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# 7.7 Mains Supply Voltage Variations-Conditioning

 Test Requirement:
 EN 50130-4:2011+A1:2014

 Test Method:
 EN 50130-4:2011+A1:2014

 Voltage max.
 AC 253V ( Umax: Unom + 10%)

 Voltage min.
 AC 195.5V (Umin: Unom - 15%)

Unom Voltage: AC 230V

Criteria: There shall be no damage, malfunction or change of status due to the

different supply voltage conditions. The EUT shall meet the

acceptance criteria for the functional test (see Clause 6 of EN 50130-

4), during the conditioning.

#### 7.7.1 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:55 % RH Atmospheric Pressure: 1010 mbar

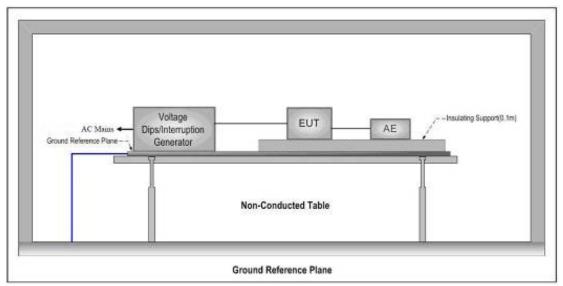
Test mode: a:working mode: keep EUT working and monitoring continual.

#### 7.7.2 Test Results:

### Test phenomenon description for the EUT:

- 1. The EUT working normal, before the conditioning.
- 2. Monitor the EUT during the conditioning period and detected no any changes in states, during the conditioning.
- 3. No degradation in the performance of the EUT was observed, after the conditioning.

#### Test Setup:





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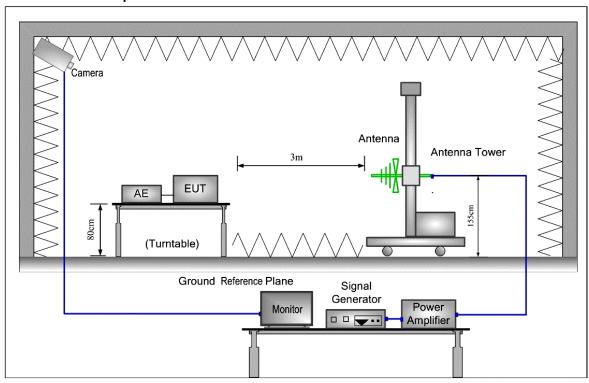
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# 7.8 RI(80M-2.7G)

Test Requirement: EN 50130-4:2011+A1:2014

Test Method: EN 61000-4-3:2006+A1:2008+A2:2010

### 7.8.1 Test Setup:



### 7.8.2 E.U.T. Operation

Operating Environment:

Temperature: 22 °C Humidity:50 % RH Atmospheric Pressure: 1003 mbar

Test mode: a:working mode: keep EUT working and monitoring continual.

#### 7.8.3 Test Results:

	_			
Frequency	Level (V/m)	EUT Face	Dwell time	Result / Observations
80MHz-2.7GHz	10	Front	3s	A
80MHz-2.7GHz	10	Back	3s	Α
80MHz-2.7GHz	10	Left	3s	А
80MHz-2.7GHz	10	Right	3s	A
80MHz-2.7GHz	10	Тор	3s	Α
80MHz-2.7GHz	10	Underside	3s	Α

### Results:

A: No degradation in the performance of the EUT was observed.

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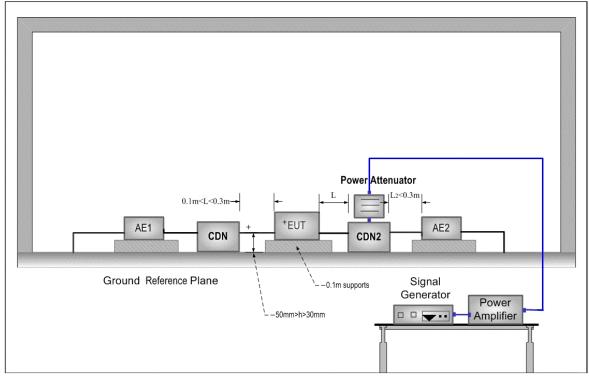
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#### 7.9 CI M(150K-100M)

Test Requirement: EN 50130-4:2011+A1:2014

Test Method: EN 61000-4-6:2014

#### 7.9.1 Test Setup:



#### 7.9.2 E.U.T. Operation

Operating Environment:

Temperature: 21 °C Humidity:51 % RH Atmospheric Pressure: 1001 mbar

Test mode: a:working mode: keep EUT working and monitoring continual.

#### 7.9.3 Test Results:

Cable port	Level (Vrms)	Direct/Coupling	Dwell time	Result / Observations
AC power port	10	Direct	3s	А

#### Results:

A: No degradation in the performance of the EUT was observed.



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#### 7.10 CI S(150K-100M)

Test Requirement: EN 50130-4:2011+A1:2014

Test Method: EN 61000-4-6:2014

7.10.1 E.U.T. Operation

Operating Environment:

Temperature: 21 °C Humidity:51 % RH Atmospheric Pressure: 1001 mbar

Test mode: a:working mode: keep EUT working and monitoring continual.

#### 7.10.2 Test Results:

Cable port	Level (Vrms)	Direct/Coupling	Dwell time	Result / Observations
Signal port	10	Coupling	3s	А

#### Results:

A: No degradation in the performance of the EUT was observed.



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#### 8 Photographs

#### 8.1 ESD Test Setup



#### 8.2 EFT(Mains) Test Setup



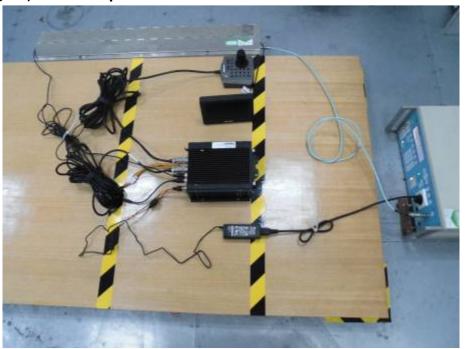
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#### 8.3 EFT(Signal) Test Setup



#### 8.4 Surge(Mains) Test Setup





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#### 8.5 V-Dips Test Setup



#### 8.6 Mains Supply Voltage Variations-Conditioning Test Setup





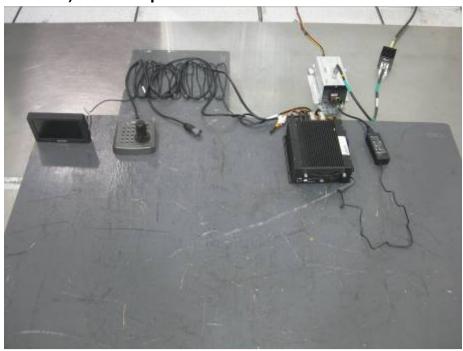
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#### 8.7 RI(80M-2.7G) Test Setup



#### 8.8 CI M(150K-100M) Test Setup

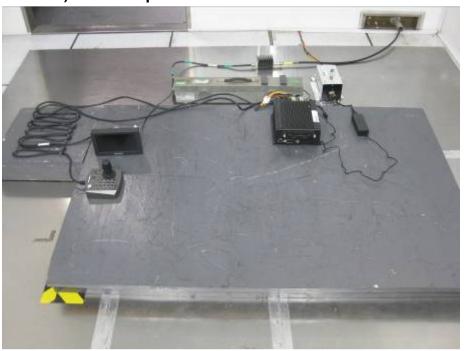




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#### 8.9 CI S(150K-100M) Test Setup



#### 8.10 CE M(150k-30M) Test Setup



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#### 8.11 CE T(150K-30M) Test Setup



#### 8.12 RE(30M-1G) Test Setup





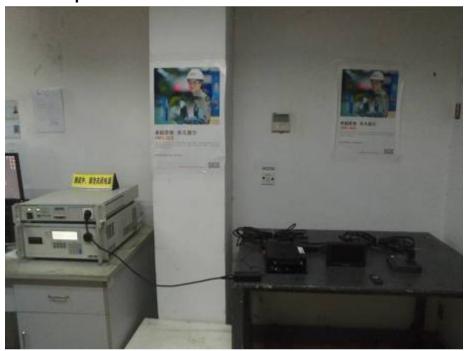
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#### 8.13 RE(above1G) Test Setup



#### 8.14 Flicker Test Setup





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#### 8.15 EUT Constructional Details







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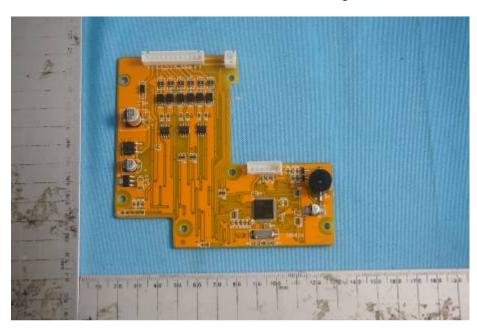


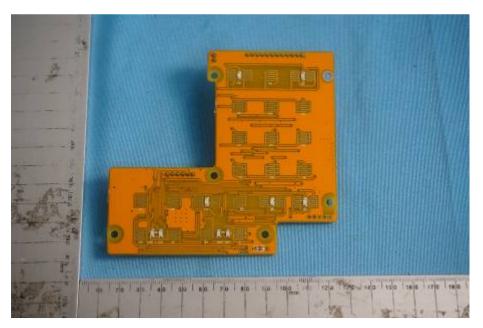




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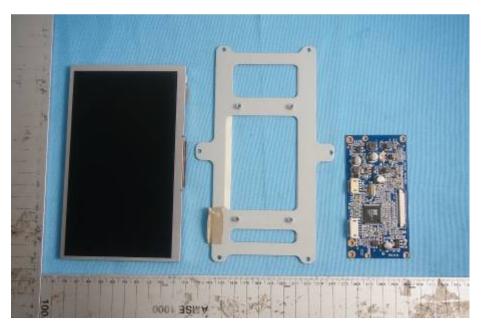




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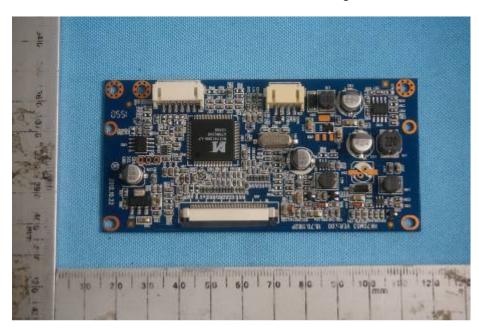






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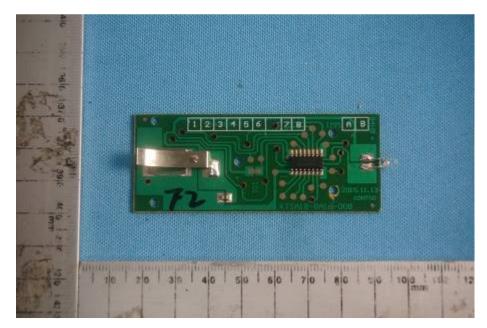




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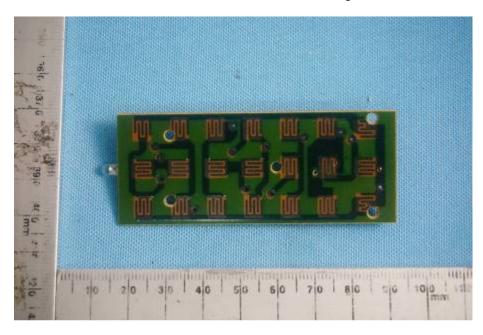






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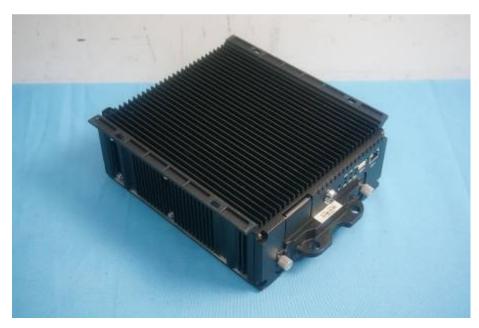




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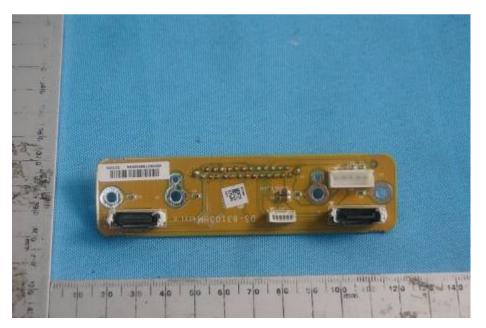




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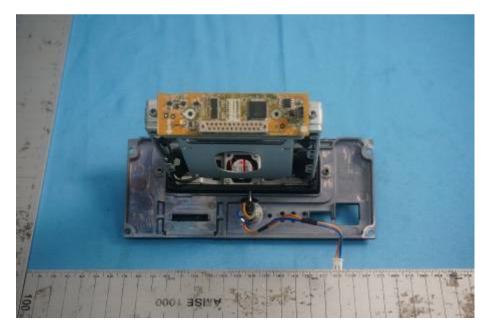




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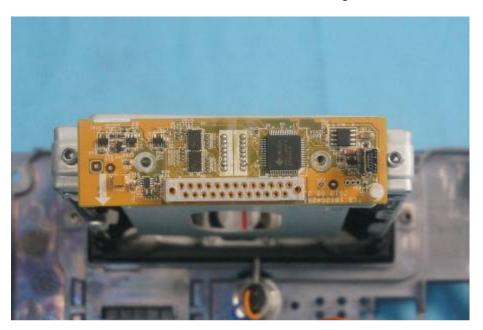






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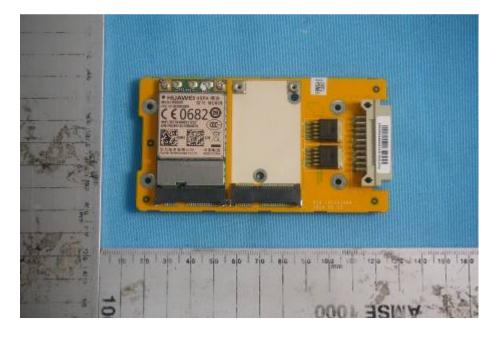




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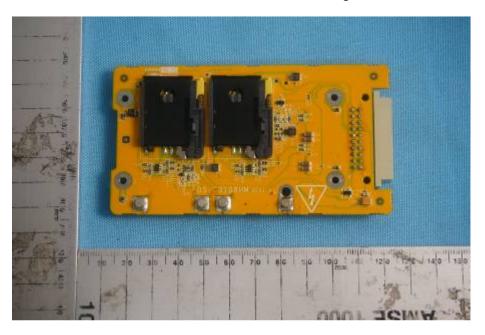


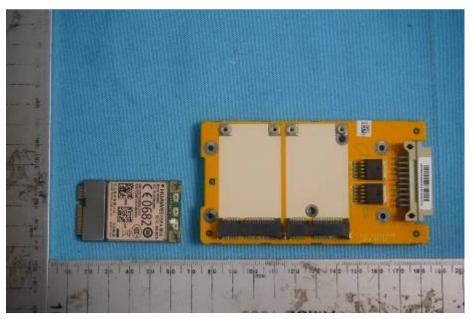




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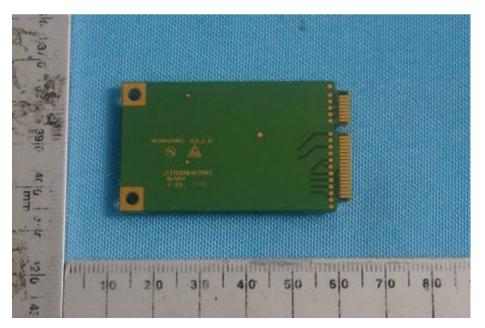




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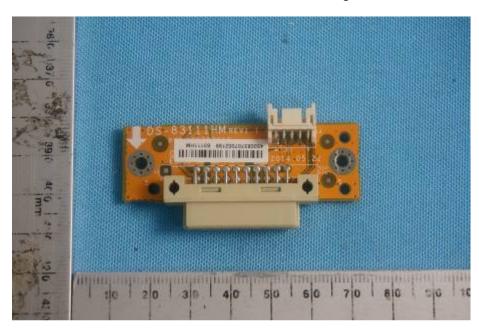


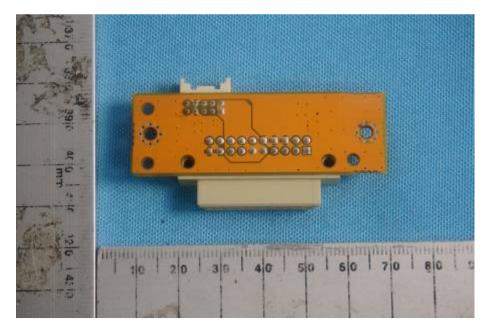




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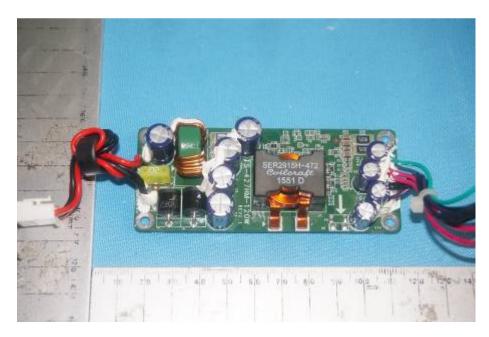




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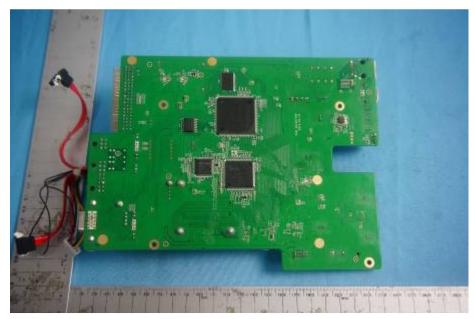




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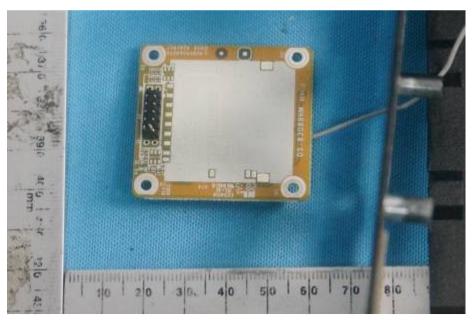




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